

**Search Notes**

Application/Control No.

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Examiner

EDMUND H. LEE

Applicant(s)/Patent under  
Reexamination

FUJIKAWA ET AL.

Art Unit

1791

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
264/259,255	9/30/2008	EHL
east		
inventor		